62.5MHZ TO 250MHZ, 1-TO-4 LVCMOS/ LVTTL ZERO DELAY CLOCK BUFFER

ICS86004-02

GENERAL DESCRIPTION

The ICS86004-02 is a high performance 1-to-4 LVCMOS/LVTTL Clock Buffer and a member of the HiPerClockS™ family of High Performance Clock Solutions from IDT. The ICS86004-02 has a fully integrated PLL and can be configured as zero delay buffer and has an input and output frequency range of 62.5MHz to 250MHz. The external feedback allows the device to achieve "zero delay" between the input clock and the output clocks. The PLL_SEL pin can be used to bypass the PLL for system test and debug purposes. In bypass mode, the reference clock is routed around the PLL and into the internal output divider.

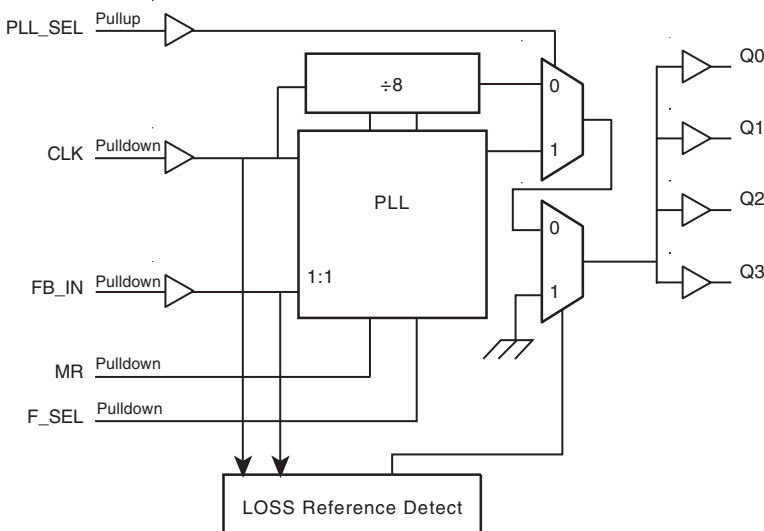ICS86004-02 has a special feature that when CLK is LOST, it will disable the output to logic LOW.

FEATURES

• Four LVCMOS/LVTTL outputs, 7Ω typical output impedance

• Single LVCMOS/LVTTL clock input

• CLK accepts the following input levels: LVCMOS or LVTTL

• Output frequency range: 62.5MHz to 250MHz

• Input frequency range: 62.5MHz to 250MHz

• External feedback for "zero delay" clock regeneration with configurable frequencies

• Fully integrated PLL

• Cycle-to-cycle jitter, (F_SEL = 1): 35ps (typical)

• Output skew: 45ps (typical)

• Supply Voltage Modes:
  (Core/Output)
   3.3V/3.3V
   3.3V/2.5V

• 5V tolerant input

• 0°C to 70°C ambient operating temperature

• Available in both standard (RoHS 5) and lead-free (RoHS 6) compliant packages

CONTROL INPUT FUNCTION TABLE

Input	Input/Output Frequency Range (MHz)	
F_SEL	Minimum	Maximum
0	125	250
1	62.5	125

BLOCK DIAGRAM

PIN ASSIGNMENT

ICS86004-02
16-Lead TSSOP
4.4mm x 5.0mm x 0.92mm package body
G Package
Top View

TABLE 1. PIN DESCRIPTIONS

Number	Name	Type		Description
1, 3, 13, 15	Q1, Q0, Q3, Q2	Output		Clock outputs. 7Ω typical output impedance. LVCMOS/LVTTL interface levels.
2, 7, 14	GND	Power		Power supply ground.
4	F_SEL	Input	Pulldown	Frequency range select input. When LOW, I/O frequency range is from 125MHz to 250Mz. When HIGH, I/O frequency range is from 62.5MHz to 125MHz. LVCMOS/LVTTL interface levels.
5	V_{DD}	Power		Core supply pin.
6	CLK	Input	Pulldown	LVCMOS/LVTTL clock input.
8	V_{DDA}	Power		Analog supply pin.
9	PLL_SEL	Input	Pullup	Selects between the PLL and reference clock as input to the dividers. When LOW, selects the reference clock (PLL Bypass). When HIGH, selects PLL (PLL Enabled). LVCMOS/LVTTL interface levels.
10	FB_IN	Input	Pulldown	Feedback input to phase detector for regenerating clocks with "zero delay". Connect to one of the outputs. LVCMOS/LVTTL interface levels.
11	MR	Input	Pulldown	Active HIGH Master Reset. When logic HIGH, the internal dividers are reset causing the outputs to go low. When logic LOW, the internal dividers and the outputs are enabled. LVCMOS/LVTTL interface levels.
12, 16	V_{DDO}	Power		Output supply pins.

NOTE: *Pullup* and *Pulldown* refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

TABLE 2. PIN CHARACTERISTICS

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C_{IN}	Input Capacitance			4		pF
R_{PULLUP}	Input Pullup Resistor			51		kΩ
$R_{PULLDOWN}$	Input Pulldown Resistor			51		kΩ
C_{PD}	Power Dissipation Capacitance (per output)	V_{DD}, V_{DDA}, V_{DDO} = 3.465V		TBD		pF
		V_{DD}, V_{DDA} = 3.465V, V_{DDO} = 2.625V		TBD		pF
R_{OUT}	Output Impedance	3.3V ± 5%	5	7	12	Ω

TABLE 3. CONTROL INPUT FUNCTION TABLE

Input	Input/Output Frequency Range (MHz)	
F_SEL	Minimum	Maximum
0	125	250
1	62.5	125

ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V_{DD}	4.6V
Inputs, V_I	-0.5V to V_{DD} + 0.5 V
Outputs, V_O	-0.5V to V_{DDO} + 0.5V
Package Thermal Impedance, θ_{JA}	89°C/W (0 lfpm)
Storage Temperature, T_{STG}	-65°C to 150°C

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

TABLE 4A. POWER SUPPLY DC CHARACTERISTICS, $V_{DD} = V_{DDA} = V_{DDO} = 3.3V\pm5\%$, T_A = -0°C TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{DD}	Core Supply Voltage		3.135	3.3	3.465	V
V_{DDA}	Analog Supply Voltage		$V_{DD} - 0.13$	3.3	V_{DD}	V
V_{DDO}	Output Supply Voltage		3.135	3.3	3.465	V
I_{DD}	Power Supply Current			85		mA
I_{DDA}	Analog Supply Current			13		mA
I_{DDO}	Output Supply Current			4		mA

TABLE 4B. POWER SUPPLY DC CHARACTERISTICS, $V_{DD} = V_{DDA} = 3.3V\pm5\%$, $V_{DDO} = 2.5V\pm5\%$, T_A = 0°C TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{DD}	Core Supply Voltage		3.135	3.3	3.465	V
V_{DDA}	Analog Supply Voltage		$V_{DD} - 0.13$	3.3	V_{DD}	V
V_{DDO}	Output Supply Voltage		2.375	2.5	2.625	V
I_{DD}	Power Supply Current			85		mA
I_{DDA}	Analog Supply Current			13		mA
I_{DDO}	Output Supply Current			4		mA

TABLE 4C. LVCMOS / LVTTL DC CHARACTERISTICS, T_A = 0°C TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V_{IH}	Input High Voltage		V_{DD} = 3.3V	2		V_{DD} + 0.3	V
V_{IL}	Input Low Voltage		V_{DD} = 3.3V	-0.3		0.8	V
I_{IH}	Input High Current	CLK, MR, FB_IN, F_SEL	$V_{DD} = V_{IN}$ = 3.465V			150	μA
		PLL_SEL	$V_{DD} = V_{IN}$ = 3.465V			5	μA
I_{IL}	Input Low Current	CLK, MR, FB_IN, F_SEL	V_{DD} = 3.465V, V_{IN} = 0V	-5			μA
		PLL_SEL	V_{DD} = 3.465V, V_{IN} = 0V	-150			μA
V_{OH}	Output High Voltage; NOTE 1		V_{DDO} = 3.465V	2.6			V
			V_{DDO} = 2.625V	1.8			V
V_{OL}	Output Low Voltage; NOTE 1		V_{DDO} = 3.465V or 2.625V			0.5	V

NOTE 1: Outputs terminated with 50Ω to V_{DDO}/2. See Parameter Measurement Information Section, *Output Load Test Circuit diagrams.*

TABLE 5A. AC CHARACTERISTICS, $V_{DD} = V_{DDA} = V_{DDO} = 3.3V \pm 5\%$, $T_A = 0°C$ TO $70°C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f_{MAX}	Output Frequency	F_SEL = 0	125		250	MHz
		F_SEL = 1	62.5		125	MHz
t_{PD}	Propagation Delay; NOTE 1	PLL_SEL = 0V, Bypass Mode		5.8		ns
t(Ø)	Static Phase Offset; NOTE 2, 4	PLL_SEL = 3.3V		330		ps
$t$sk(o)	Output Skew; NOTE 3, 4	PLL_SEL = 0V		60		ps
$t$jit(cc)	Cycle-to-Cycle Jitter; NOTE 4	F_SEL = 0		40		ps
		F_SEL = 1		35		ps
t_L	PLL Lock Time				1	mS
t_R / t_F	Output Rise/Fall Time	20% to 80%		550		ps
odc	Output Duty Cycle	F_SEL = 0		50		%
		F_SEL = 1		50		%

NOTE 1: Measured from the differential input crossing point to the output at $V_{DDO}/2$.
NOTE 2: Defined as the time difference between the input reference clock and the average feedback input signal when the PLL is locked and the input reference frequency is stable.
NOTE 3: Defined as skew between outputs at the same supply voltages and with equal load conditions.
Measured at $V_{DDO}/2$.
NOTE 4: This parameter is defined in accordance with JEDEC Standard 65.

TABLE 5B. AC CHARACTERISTICS, $V_{DD} = V_{DDA} = 3.3V \pm 5\%$, $V_{DDO} = 2.5V \pm 5\%$, $T_A = 0°C$ TO $70°C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f_{MAX}	Output Frequency	F_SEL = 0	125		250	MHz
		F_SEL = 1	62.5		125	MHz
t_{PD}	Propagation Delay; NOTE 1	PLL_SEL = 0V, Bypass Mode		6.2		ns
t(Ø)	Static Phase Offset; NOTE 2, 4	PLL_SEL = 3.3V		285		ps
$t$sk(o)	Output Skew; NOTE 3, 4	PLL_SEL = 0V		45		ps
$t$jit(cc)	Cycle-to-Cycle Jitter; NOTE 4	F_SEL = 0		45		ps
		F_SEL = 1		35		ps
t_L	PLL Lock Time				1	mS
t_R / t_F	Output Rise/Fall Time	20% to 80%		500		ps
odc	Output Duty Cycle	F_SEL = 0		50		%
		F_SEL = 1		50		%

NOTE 1: Measured from the differential input crossing point to the output at $V_{DDO}/2$.
NOTE 2: Defined as the time difference between the input reference clock and the average feedback input signal when the PLL is locked and the input reference frequency is stable.
NOTE 3: Defined as skew between outputs at the same supply voltages and with equal load conditions.
Measured at $V_{DDO}/2$.
NOTE 4: This parameter is defined in accordance with JEDEC Standard 65.

PARAMETER MEASUREMENT INFORMATION
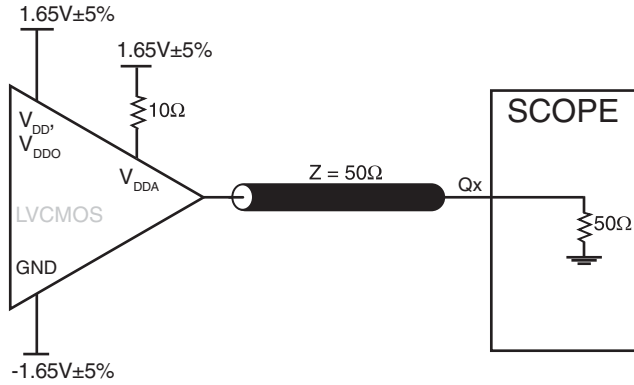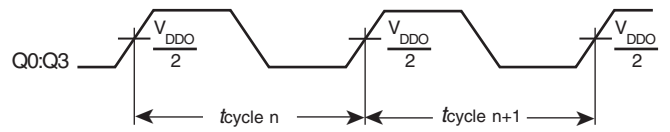
3.3V CORE/3.3V OUTPUT LOAD AC TEST CIRCUIT
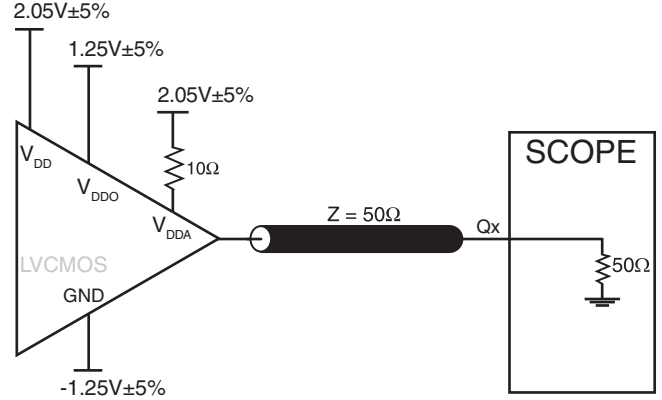
3.3V CORE/2.5V OUTPUT LOAD AC TEST CIRCUIT
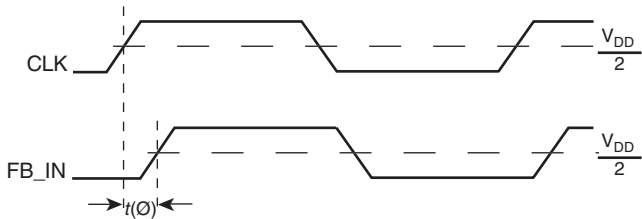
$t(\emptyset)$ mean = Static Phase Offset
(where $t(\emptyset)$ is any random sample, and $t(\emptyset)$ mean is the average
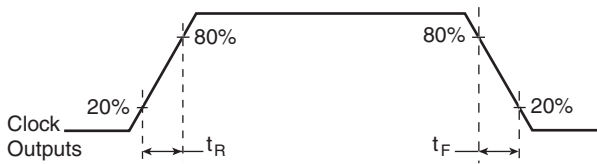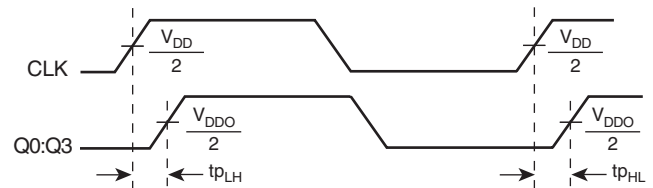of the sampled cycles measured on controlled edges)

STATIC PHASE OFFSET

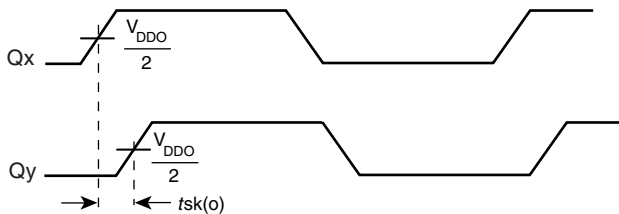$$t\text{jit(cc)} = t\text{cycle n} - t\text{cycle n+1}$$
$$1000 \text{ Cycles}$$

CYCLE-TO-CYCLE JITTER

OUTPUT RISE/FALL TIME

PROPAGATION DELAY

OUTPUT SKEW
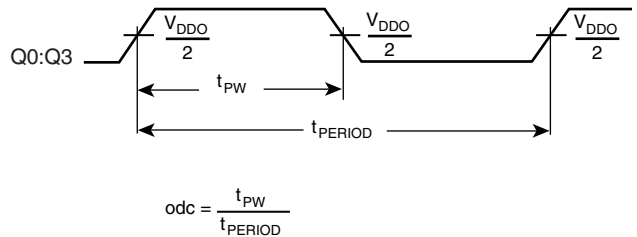
$$\text{odc} = \frac{t_{PW}}{t_{PERIOD}}$$

OUTPUT DUTY CYCLE/PULSE WIDTH/PERIOD

APPLICATION INFORMATION

POWER SUPPLY FILTERING TECHNIQUES

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. The ICS86004-02 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL. V_{DD}, V_{DDA}, and V_{DDO} should be individually connected to the power supply plane through vias, and bypass capacitors should be used for each pin. To achieve optimum jitter performance, power supply isolation is required. *Figure 1* illustrates how a 10Ω resistor along with a 10µF and a .01µF bypass capacitor should be connected to each V_{DDA}. The 10Ω resistor cn also be replaced by a ferrite bead.
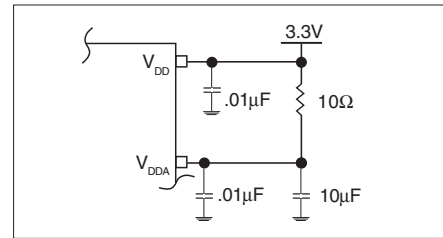

FIGURE 1. POWER SUPPLY FILTERING

RECOMMENDATIONS FOR UNUSED INPUT AND OUTPUT PINS

INPUTS:

LVCMOS CONTROL PINS:
All control pins have internal pull-ups or pull-downs; additional resistance is not required but can be added for additional protection. A 1kΩ resistor can be used.

OUTPUTS:

LVCMOS OUTPUT:
All unused LVCMOS output can be left floating. There should be no trace attached.

RELIABILITY INFORMATION

TABLE 6. θ_{JA} VS. AIR FLOW TABLE FOR 16 LEAD TSSOP

θ_{JA} by Velocity (Linear Feet per Minute)			
	0	**200**	**500**
Single-Layer PCB, JEDEC Standard Test Boards	137.1°C/W	118.2°C/W	106.8°C/W
Multi-Layer PCB, JEDEC Standard Test Boards	89.0°C/W	81.8°C/W	78.1°C/W

NOTE: Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

TRANSISTOR COUNT

The transistor count for ICS86004-02 is: 2782

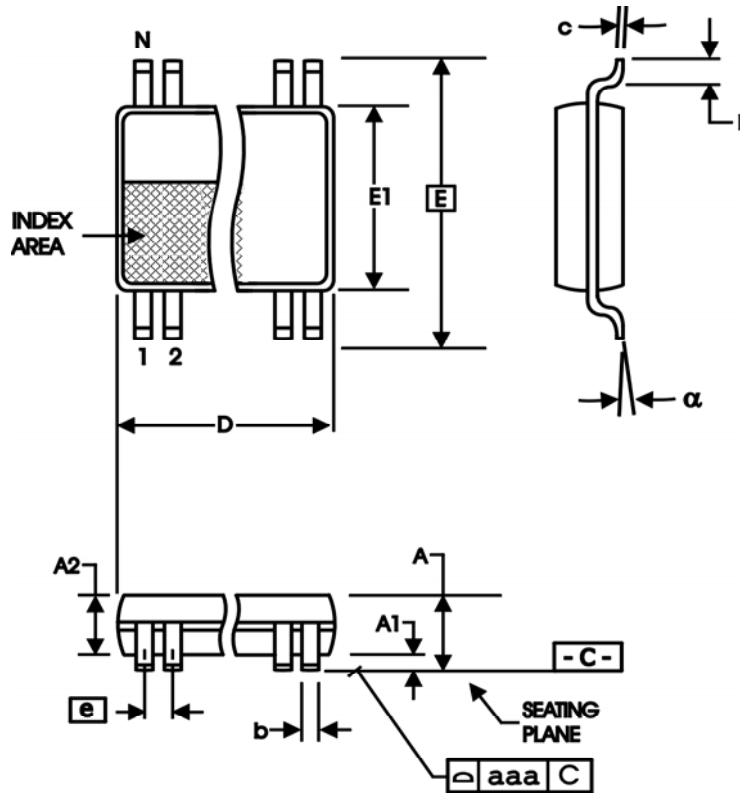**PACKAGE OUTLINE - G SUFFIX FOR 16 LEAD TSSOP**

TABLE 7. PACKAGE DIMENSIONS

SYMBOL	Millimeters	
	Minimum	Maximum
N	16	
A	--	1.20
A1	0.05	0.15
A2	0.80	1.05
b	0.19	0.30
c	0.09	0.20
D	4.90	5.10
E	6.40 BASIC	
E1	4.30	4.50
e	0.65 BASIC	
L	0.45	0.75
α	0°	8°
aaa	--	0.10

Reference Document: JEDEC Publication 95, MO-153

TABLE 8. ORDERING INFORMATION

Part/Order Number	Marking	Package	Count	Temperature
ICS86004AG-02	86004A02	16 Lead TSSOP	Tube	0°C to 70°C
ICS86004AG-02T	86004A02	16 Lead TSSOP	2500 Tape & Reel	0°C to 70°C
ICS86004AG-02LF	TBD	16 Lead "Lead-Free" TSSOP	Tube	0°C to 70°C
ICS86004AG-02LFT	TBD	16 Lead "Lead-Free" TSSOP	2500 Tape & Reel	0°C to 70°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

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